Notice of References Cited

Application/Control No. 10/678,004	Applicant(s)/Pater Reexamination RIBARICH, THOM	
Examiner	Art Unit	
Hargobind S Sawhney	2875	Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,582,269 B2	06-2003	Sakai et al.	445/26
	В	US-6,494,730 B1	12-2002	Yan, Ellis	439/226
	С	US-6,492,773 B2	12-2002	Gyoten et al.	315/56
	D	US-6,150,761	11-2000	Eberson et al.	315/61
	E.	US-6,437,502 B1	08-2002	Nishio et al.	313/493
	F	US-6,411,524 B1	06-2002	Chen et al.	361/803
	G	US-5,971,564	10-1999	Wang, Chen-Feng	362/263
	Η	US-5,961,204	10-1999	Martich et al.	362/295
	_	US-5,955,841	09-1999	Moisin et al.	315/56
	J	US-5,545,950	08-1996	Cho, Sung H.	315/56
	К	US-5,164,635	11-1992	De Jong et al.	315/58
	L	US-4,961,027	10-1990	Muessii, Daniel	315/58
	М	US-4,739,222	04-1988	Nomoto et al.	315/57

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 11025751 A	01-1999	Japan	Matsushita	
	0					
	Р					
	O					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*	·_	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.